# TSU CONS Reliaiblity Study – Meeting 4

Simulation scenarios parameters and inputs



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#### **Simulations** Assumptions

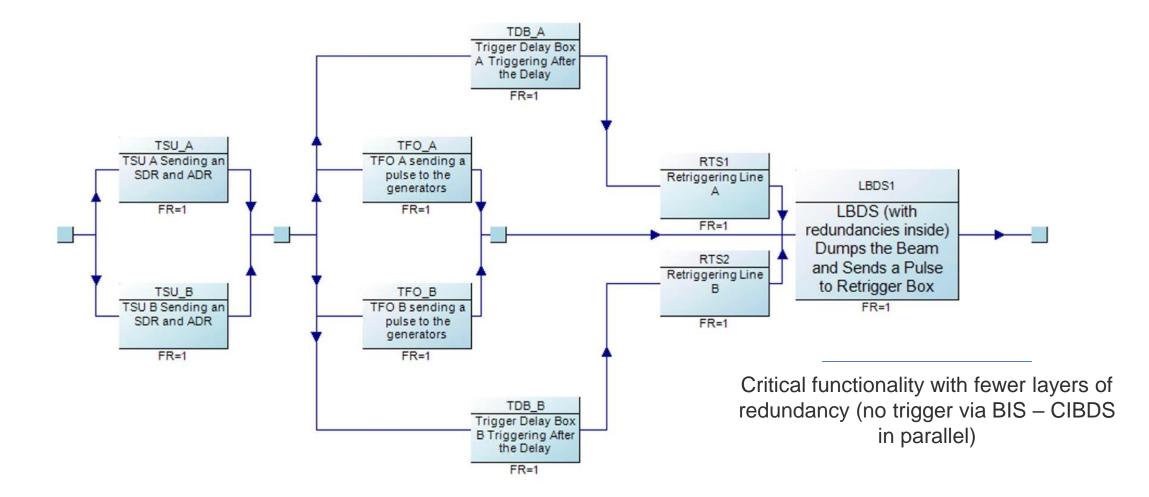
- Hybrid Monte-Carlo analytical model
  - Each iteration draws the mission length of from a probability distribution with mean set to 12 hours.
- Assumptions:
  - Each mission ends with a check (IPOC/XPOC, Post Mortem, active surveillance) which removes blinds failures and brings the system back to "as good as new" state. <u>Assuming full coverage</u> (see simulations for various mission lengths).
  - Each year has 250 operational days.
  - Not considering software or other common cause errors.

#### • Failure rates:

- TFO assigned 548 FITS (TO1 "TO unit failed open", RF's thesis, Table A.6)
- TDU/TDB assigned 130 FITS (V. Vatensever thesis, Equation 5.9)
- RTS assigned 78 FITS (L "Re-triggering line failed", RF's thesis, Table A.7)
- LBDS assigned ("< 14 MKD available", RF's thesis, 0.084 FITS, Table 7.2)



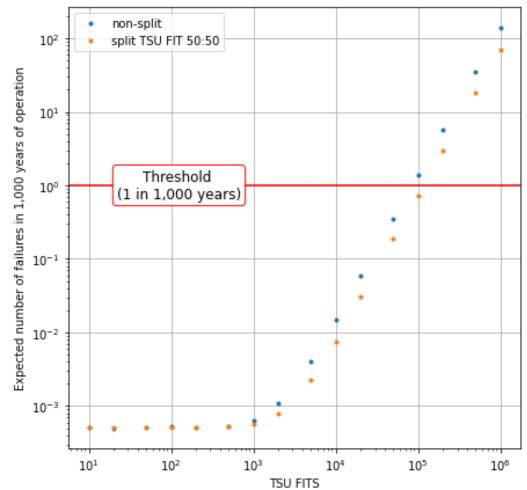
### Simulated model Async Beam Dump via TSU (not triggered by BIS)



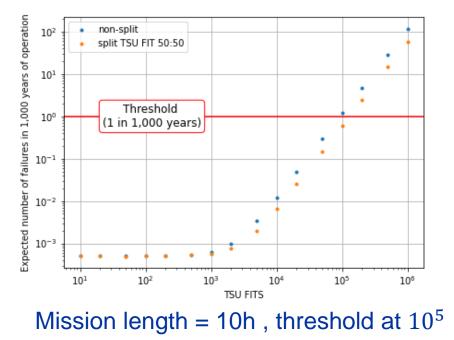


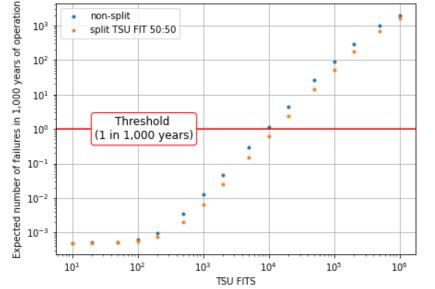
# Simulation results Sensitivity analysis of the TSU FITS

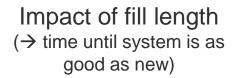
- Accceptable failure probability threshold
  - 1 failure every 1,000 years.
  - **Fulfilled** as long as FITS of TSU's blind failures << 10^5 (equivalent to 0.6 failures per 250 days)
  - Result should have at least an order of magnitude margin to account for other critical scenrios.
- Mission length sampled from the exponential distribution with mean of 12 hours.
- Two model variants considered:
  - **Blue dots:** model without the inter-TSU dump request communication.
  - Orange dots: model assuming that each TSU exchanges information with the other one (parts responsible for receiving and transmitting have the failure rate divided equally).

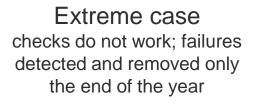


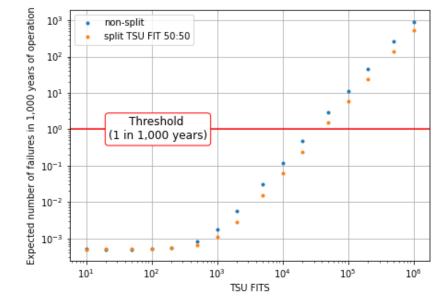




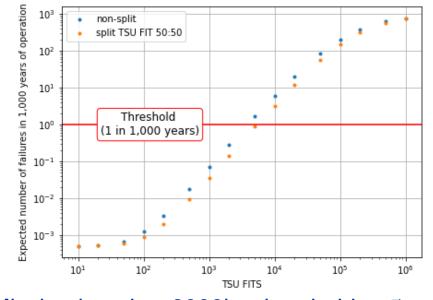








Mission length = 100h , threshold at  $3 \times 10^4$ 

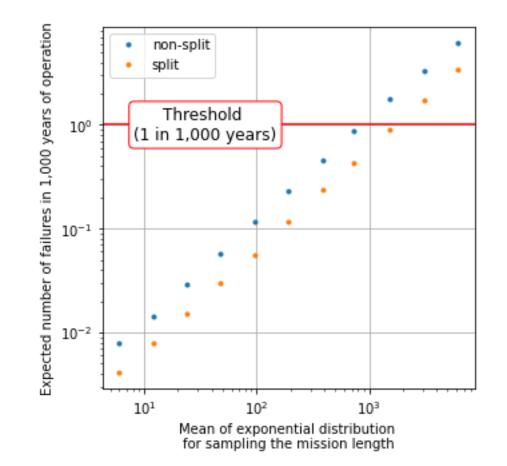


#### Mission length = 6000h , threshold at $5 \times 10^3$



## Simulation results Varying mission length

- TSU failure rate set to 10,000 FIT.
- Increasing the time between missions increases the probability of a critical failure.
  - Longer missions mean longer periods without checks, removing the possibility for the system to be repaired.
  - In effect, lack of checks leads to accumulation of the failures in redundant paths.





#### **Simulation** First takeaways

- C0. With current assumptions, estimated TSU blind failure rate requirement not very stringent.
- C1. Inter-TSU dump request doesn't make much difference.
  - It provides additional advantage but does not seem to be changing the results significantly.
- C2. More important: ensuring that checks cover all failures.

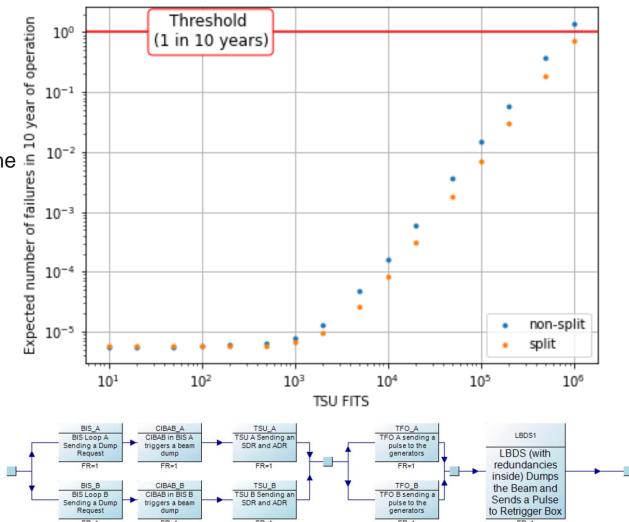


# Synchronous Beam Dump (triggered by BIS)

- Model of triggering an asynchronous beam dump in effect of a failure in the standard triggering
  - Failure more likely (less protection layers), but given the relaxed threshold (1 asynchronous beam dump per year), FITS are not a problem

#### Simulation

- Completed for a mission length sampled from the exponential distribution with mean of **12 hours**
- Increasing or decreasing that value leads to same observations as before: more time between checks increases the risk of a critical failure
  - For comparison, the threshold is reached for a TSL with 10,000 FIT when mission length is ~1,000 hours.





# **Other critical failures in R. Filippini's thesis**

- When does the BETS trigger a dump? (Unable to trigger a dump request is classified as a critical failure in R. Filippini's thesis)
  - The thesis explains the failure mode as the system being blind to powering failures (unable to detect an energy tracking error).
  - Or can it only cause an erratic energy measurement?





- Extension of simulation model & sensitivity analysis
  - Increased failure rate of other systems
  - Beam dump via TSU and CIBDS (triggered by BIS) model
- Depending on status of the detailed TSU design could start bottom-up analysis
- Top-level analysis of LBDS Power Distribution





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